ABSTRACT

An improved barrier stack for inhibiting diffusion of atoms or molecules, such as  $O_2$  is disclosed. barrier stack is particularly useful in capacitor over plug structures to prevent plug oxidation which can adversely impact the refliability of the structures. barrier stack includes first and second barrier layers having mismatched grain boundaries. The barrier layers are selected from, for example, Ir, Ru, Pd, Rh, or alloys 10 By providing mismatched grain boundaries, the interface of the layers block the diffusion path of To further enhance the barrier properties, the first barrier layer is passivated with O2 using, for example, a rapid thermal oxidation. The RTO forms a thin 15 oxide layer on the surface of the first barrier layer. The oxide layer can advantageously promote mismatching of

the grain boundaries of the first and second barrier

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